

| Application/Control No. | Applicant(s)/Patent under Reexamination |
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| 10/620,163 | HASEBE ET AL. |
| Examiner | Art Unit |
| Truc T. Chuong | 2179 |

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| SEARCH NOTES (INCLUDING SEARCH STRATEGY) | | | | |
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| | DATE | EXMR | | |
| EAST (USPAT, USOCR, USPG_PUB, DERWENT, EPO, JPO, IBM_TAB) NPL (01/18/08) (IEEE, ACM) | 01/08/08 | ű | | |
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